TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (兀MOS )

# 2SK3760

#### Switching Regulator Applications

- Low drain-source ON resistance: RDS (ON) = 1.7 (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 2.5S$  (typ.)
- Low leakage current: IDSS = 100 µ A (VDS = 600 V)
- Enhancement-mode:  $V_{th} = 2.0 \sim 4.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_{D} = 1 \text{ mA}$ )

#### Maximum Ratings (Ta = 25°C)

| Characte                             | ristics                       | Symbol           | Rating                   | Unit |
|--------------------------------------|-------------------------------|------------------|--------------------------|------|
| Drain-source voltage                 |                               | V <sub>DSS</sub> | 600                      | V    |
| Drain-gate voltage (F                | $R_{GS} = 20 \text{ k}\Omega$ | $V_{DGR}$        | 600                      | V    |
| Gate-source voltage                  |                               | $V_{GSS}$        | ±30                      | V    |
| Drain current                        | DC (Note 1)                   | l <sub>D</sub>   | 3.5                      | Α    |
|                                      | Pulse (t = 1 ms)<br>(Note 1)  |                  |                          |      |
| Drain power dissipat                 | ion (Tc = 25°C)               | $P_D$            | 60                       | W    |
| Single pulse avalance                | he energy<br>(Note 2)         | E <sub>AS</sub>  | 6.3                      | mJ   |
| Avalanche current                    |                               | lar D            | ataSheet4U.c             | am A |
| Repetitive avalanche energy (Note 3) |                               | E <sub>AR</sub>  | 6                        | mJ   |
| Channel temperature                  | )                             | T <sub>ch</sub>  | T <sub>ch</sub> 150      |      |
| Storage temperature                  | range                         | T <sub>stg</sub> | T <sub>stg</sub> -55~150 |      |

#### **Thermal Characteristics**

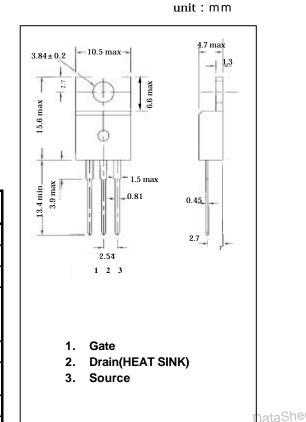
| Characteristics                        | Symbol                 | Max  | Unit |  |
|--|------------------------|------|------|--|
| Thermal resistance, channel to case    | R <sub>th (ch-c)</sub> | 2.08 | °C/W |  |
| Thermal resistance, channel to ambient | R <sub>th (ch-a)</sub> | 83.3 | °C/W |  |

Note 1: Please use devices on conditions that the channel temperature is below 150 °C.

Note 2:  $V_{DD} = 90 \text{ V}$ ,  $T_{ch} = 25^{\circ}\text{C}$  (initial), L = 0.9 mH,  $I_{AR} = 3.5 \text{ A}$ ,  $R_G = 25 \Omega$ 

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

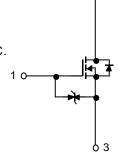


JEDEC TO-220AB

JEITA SC-46

TOSHIBA

Weight: 2.0g(typ.)



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### **Electrical Characteristics (Ta = 25°C)**

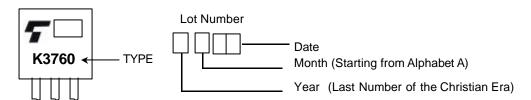
| Char                         | acteristics  | Symbol               | Test Condition  | Min | Тур. | Max | Unit |
|------------------------------|--|----------------------|---|-----|------|-----|------|
| Gate leakage cu              | rrent  | lgss                 | $V_{GS} = \pm 25  V, V_{DS} = 0  V$   | _   | _    | ±10 | μΑ   |
| Gate-source bre              | urce breakdown voltage $V_{(BR) GSS}$ $I_D = \pm 10 \mu A, V_{GS} = 0 V$ |                      | $I_D = \pm 10 \mu A, V_{GS} = 0 V$  | ±30 |      | _   | V    |
| Drain cut-off curi           | rent   | loss                 | $V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$                                | _   | _    | 100 | μΑ   |
| Drain-source bre             | akdown voltage   | V (BR) DSS           | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$                                   | 600 | _    | _   | V    |
| Gate threshold v             | oltage   | $V_{th}$             | $V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$                                   | 2.0 | _    | 4.0 | V    |
| Drain-source ON              | l resistance   | R <sub>DS (ON)</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.8 A                                |     | 1.7  | 2.2 | Ω    |
| Forward transfer             | admittance   | Y <sub>fs</sub>      | $V_{DS} = 10 \text{ V}, I_D = 1.8 \text{ A}$                                  | 0.7 | 2.5  | _   | S    |
| Input capacitance            |  | C <sub>iss</sub>     | V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz                      | _   | 550  | _   | pF   |
| Reverse transfer capacitance |  | C <sub>rss</sub>     |   | _   | 6    | _   |      |
| Output capacitance           |  | Coss                 |   | _   | 60   | _   |      |
| Switching time               | Rise time  | t <sub>r</sub>       | $V_{GS}$ $V_{DD} = 1.8 \text{ A}$ $V_{OUT}$ $V_{GS}$ $V_{DD} = 200 \text{ V}$ | _   | 12   |     |      |
|                              | Turn-on time   | t <sub>on</sub>      |   | _   | 45   |     |      |
|                              | Fall time  | t <sub>f</sub>       |   | _   | 13   |     | ns   |
|                              | Turn-off time  | t <sub>off</sub>     | Duty ≦ 1%, t <sub>w</sub> = 10 μs   | _   | 80   |     |      |
| Total gate charge            |  | $Q_g$                |   | _   | 16   | _   |      |
| Gate-source charge           |  | Q <sub>gs</sub>      | $V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$     |     | 10   |     | nC   |
| Gate-drain charge            |  | Q <sub>gd</sub>      | ]   | _   | 6    | _   |      |

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#### Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                           | Symbol           | Test Condition                                  | Min | Тур. | Max  | Unit |
|---|------------------|---|-----|------|------|------|
| Continuous drain reverse current (Note 1) | l <sub>DR</sub>  | _   | _   | _    | 3.5  | Α    |
| Pulse drain reverse current (Note 1)      | I <sub>DRP</sub> | _   | _   | _    | 14   | Α    |
| Forward voltage (diode)                   | $V_{DSF}$        | $I_{DR} = 3.5 \text{ A}, V_{GS} = 0 \text{ V}$  | _   |      | -1.7 | V    |
| Reverse recovery time                     | t <sub>rr</sub>  | $I_{DR} = 3.5 \text{ A}, V_{GS} = 0 \text{ V},$ | _   | 1400 | _    | ns   |
| Reverse recovery charge                   | Q <sub>rr</sub>  | $dI_{DR}/dt = 100 A/\mu s$                      | _   | 9    | _    | μС   |

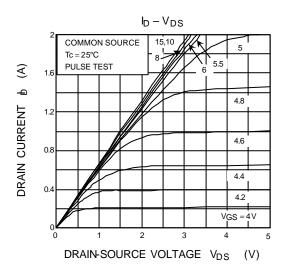
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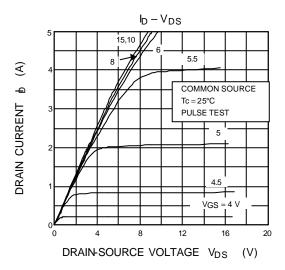


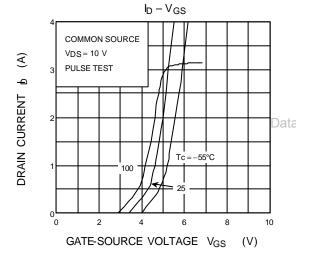
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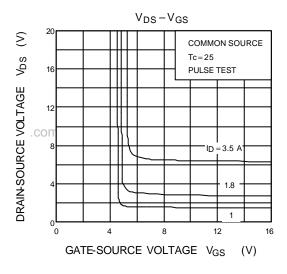
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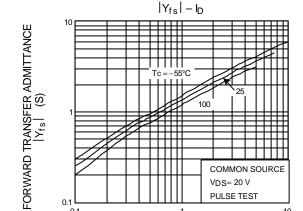
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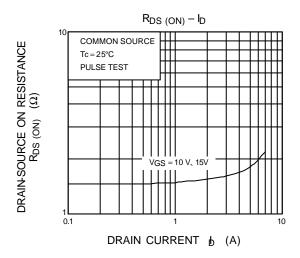




DRAIN CURRENT b (A)

PULSE TEST

10

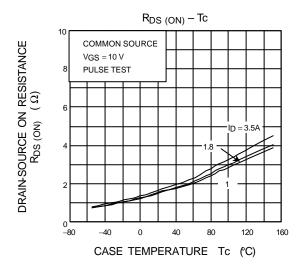


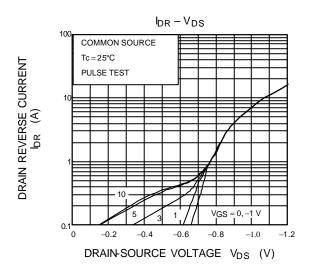
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CAPACITANCE - V<sub>DS</sub>

10000

1000

1000

1000

Ciss

Coss

taSr

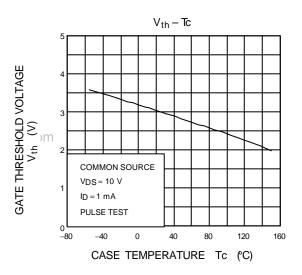
COMMON SOURCE

VGS = 0 V

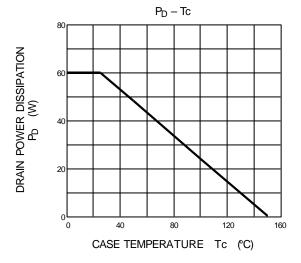
f = 1 MHz

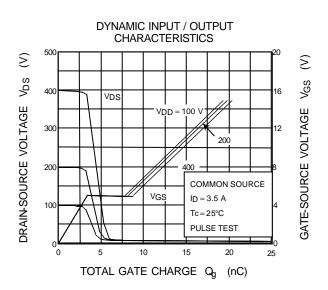
Tc = 25°C

DRAIN-SOURCE VOLTAGE V<sub>DS</sub> (V)



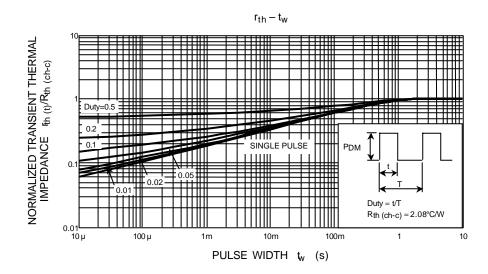
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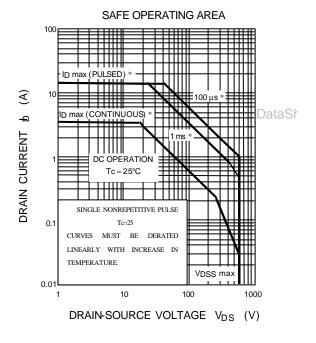


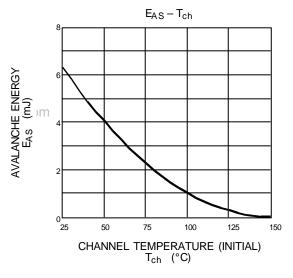
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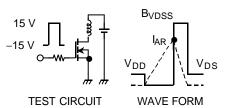
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$$\begin{array}{l} R_G = 25~\Omega \\ V_{DD} = 90~V,~L = 0.9~mH \end{array} \qquad \mathring{A}AS^=$$

$$\mathring{A}_{AS} = \frac{1}{2} \cdot L \cdot \mathring{I}^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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Handbook" etc..

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